

Search Notes				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/786,811	ZHENG ET AL.	
				Examiner	Art Unit	
				Dawn Garrett	1774	

SEARCHED			
Class	Subclass	Date	Examiner
428	690	10/18/06	Qff
428	917		
313	504		
313	506		
257	40		
427	66		
(see EAST search printout)			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Interference Search			
(see EAST search -			
USPTO Pub database			
printout	-7/2/07		Dly

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Name Search	10/18/06	Qff
EAST search (see attached printout)	10/18/06	Qff
STIC - EIC search of structure (see printout)	5/2005	Qff
STIC search (see printout)	2/20/07 And 2/22/07	Qff
EAST search (see printout)	5/11/07	Qff
EAST search (see printout)	7/2/07	Dly
Inventor Name search	7/2/07	Qff
Reviewed prior STIC searches	7/2/07	Dly